

ESD5Z24

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ESD5Z24

Surface Mount Uni-Directional TVS For ESD Protection Diode 24V

Features

- 504 Watts peak pulse power per line ($t_p=8/20\mu s$)
- Protects one I/O or power line.
- Low clamping voltage.
- Working voltage 24V.
- Low leakage current.
- Provide transient protection:
IEC 61000-4-2 (ESD) $\pm 30kV$ (Air & Contact).
IEC 61000-4-4 (EFT) 40A (5/50ns).
IEC 61000-4-5 (Lightning) 9A (8/20 μs).
- Lead-free parts meet RoHS requirements.
- Suffix "-H" indicates Halogen-free part, ex.ESD5Z24-H.

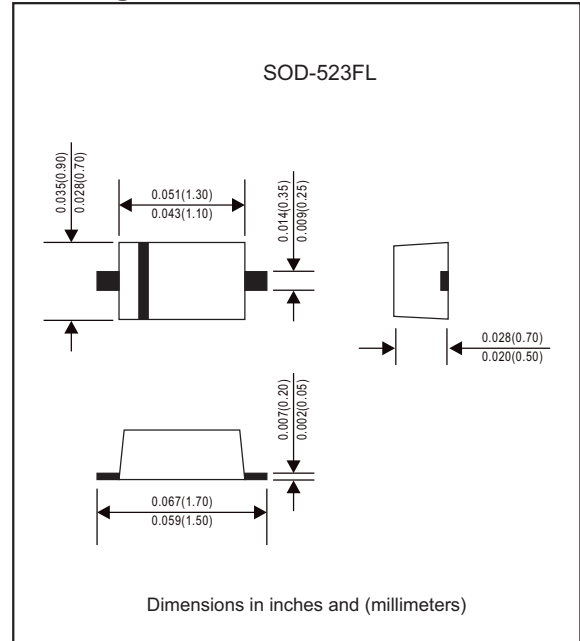
Applications

- Cellular Handsets & Accessories
- Personal Digital Assistants (PDAs)
- Notebooks & Handhelds
- Portable Instrumentation, Digital Cameras, MP3 players

Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : Molded plastic, SOD-523FL
- Terminals : Solder plated, solder able per MIL-STD-750, Method 2026
- Polarity : Indicated by cathode band
- Mounting Position : Any
- Weight : Approximated 0.002 gram

Package outline



Maximum ratings (At $T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Peak pulse power ($t_p=8/20\mu s$)	P_{PP}	504	W
Electrostatic discharge voltage (IEC61000-4-2 Contact & Air)	V_{ESD}	± 30	kV
Peak pulse current ($t_p=8/20\mu s$, IEC61000-4-5)	I_{PP}	9	A
Operating temperature range	T_J	-55 to +125	$^\circ C$
Storage temperature range	T_{STG}	-55 to +150	$^\circ C$

Electrical characteristics (At $T_A=25^\circ C$ unless otherwise noted)

Parameter	Conditions	Symbol	Min.	Typ.	Max.	Unit
Reverse stand-off voltage		V_{RWM}			24	V
Reverse breakdown voltage	$I_T=1mA$	V_{BR}	26.7			V
Reverse leakage current	$V_{RWM}=24V$	I_R			500	nA
Forward voltage	$I_F=10mA$	V_F	0.6		1.0	V
Clamping voltage	$I_{PP}=9A$, $t_p=8/20\mu s$	V_C		52	56	V
Dynamic resistance, Note 1,2	$T_{LP}=0.2/100ns$	R_{DYN}		0.4		Ω
ESD clamping voltage, Note 1	$I_{PP}=4A$, $t_p=0.2/100ns$ (TLP)	V_C		33		V
	$I_{PP}=16A$, $t_p=0.2/100ns$ (TLP)	V_C		37.7		V
Junction capacitance	$V_R=0V$, $f=1MHz$	C_J		45	50	pF

Note : 1. TLP setting : $t_p=100ns$, $t_r=0.2ns$, I_{TLP} and V_{TLP} sample window : $t_1=70ns$ to $t_2=90ns$.
2. Dynamic resistance calculated from $I_{PP}=4A$ to $I_{PP}=16A$ using "Best Fit".

Rating and characteristic curves(ESD5Z24)

Figure 1: Peak Pulse Power vs. Pulse Time

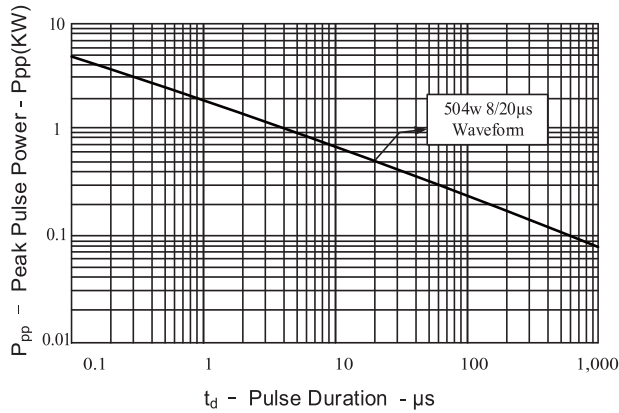


Figure 2: Power Derating Curve

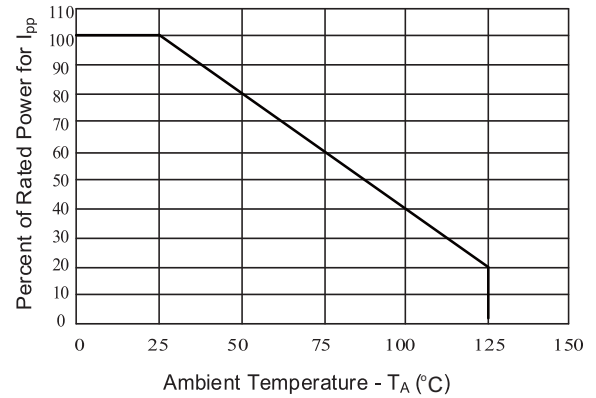


Figure 3: Clamping Voltage vs. Peak Pulse Current

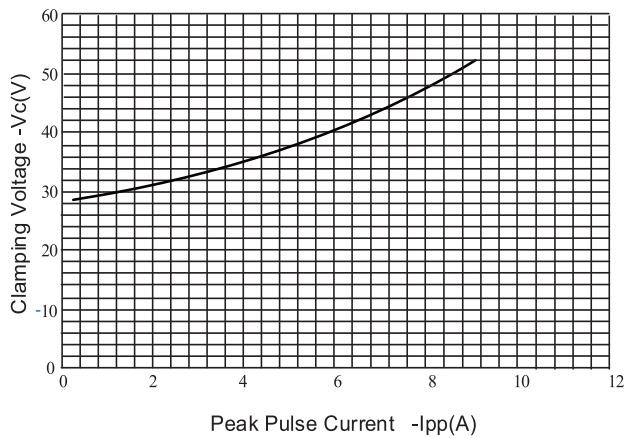


Figure 4: Normalized Junction Capacitance vs. Reverse Voltage

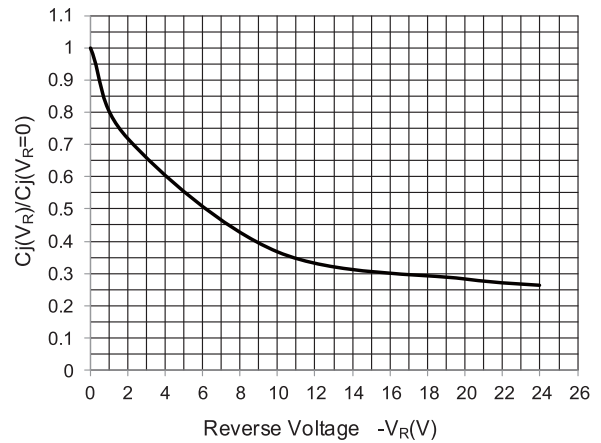


Figure 5: 8/20 μs Pulse Waveform

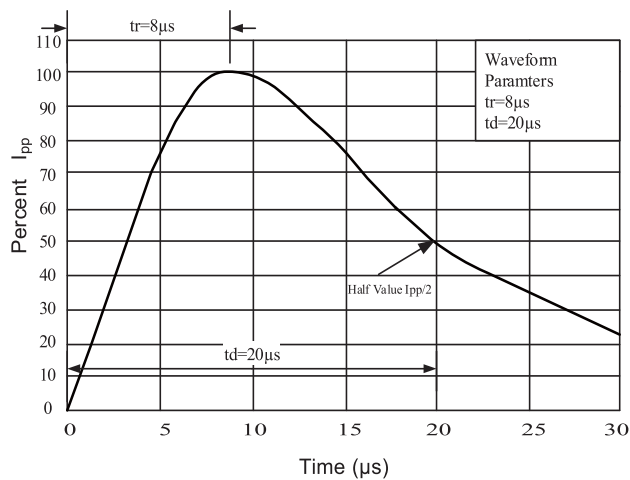
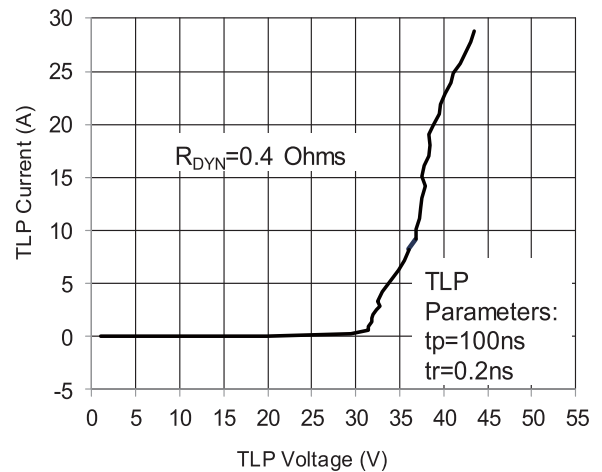


Figure 6: TLP I-V Curve



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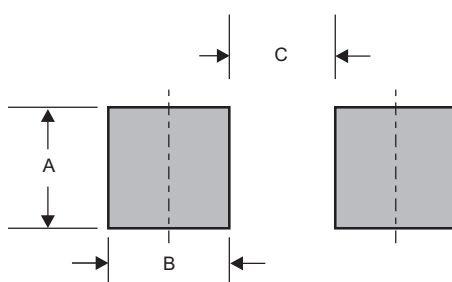
Pinning information

Pin	Simplified outline	Symbol
Pin1 cathode Pin2 anode		

Marking

Type number	Marking code
ESD5Z24	24

Suggested solder pad layout

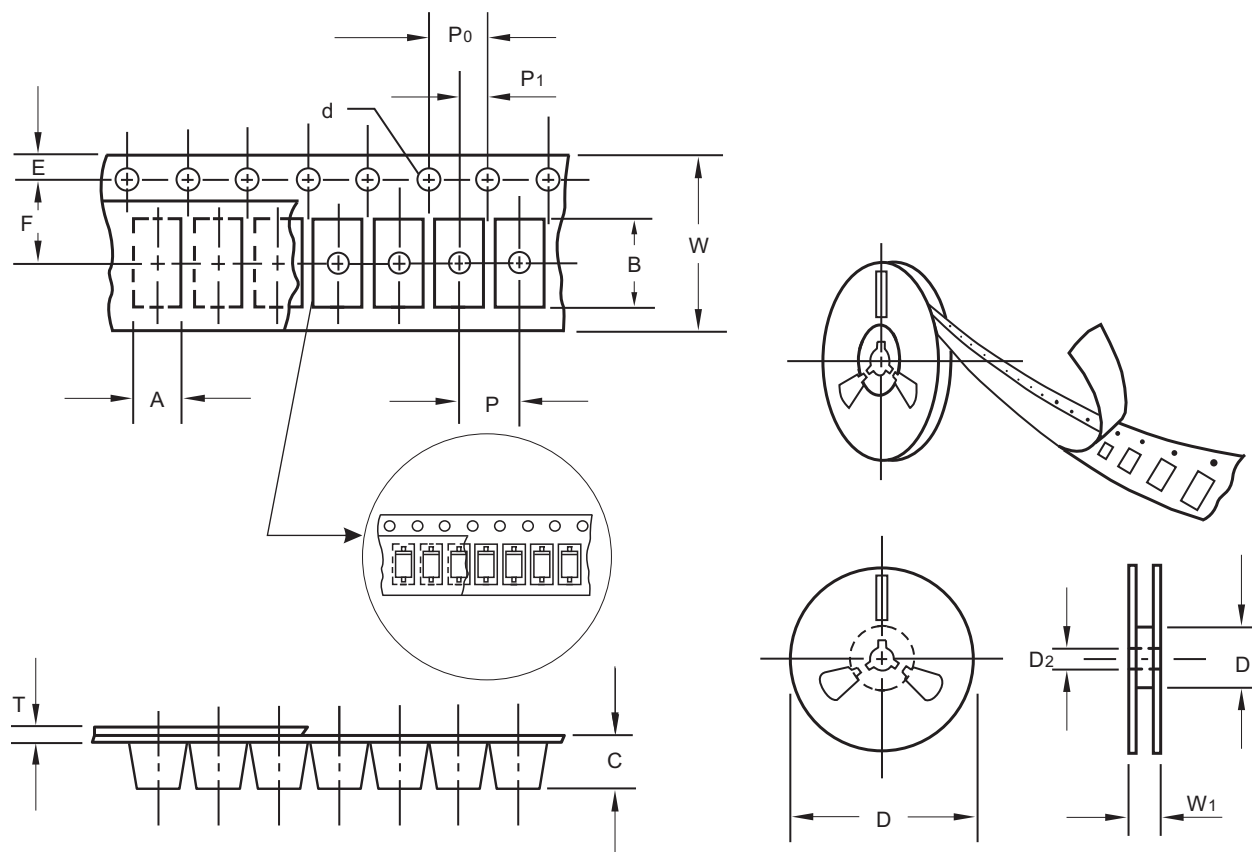


Dimensions in inches and (millimeters)

PACKAGE	A	B	C
SOD-523FL	0.032 (0.80)	0.024 (0.60)	0.044 (1.10)

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Packing information



unit:mm

Item	Symbol	Tolerance	SOD-523FL
Carrier width	A	0.1	0.90
Carrier length	B	0.1	1.94
Carrier depth	C	0.1	0.76
Sprocket hole	d	0.1	1.50
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D ₁	min	50.00
Feed hole diameter	D ₂	0.2	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	2.00
Sprocket hole pitch	P ₀	0.1	4.00
Embossment center	P ₁	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W ₁	1.0	9.50

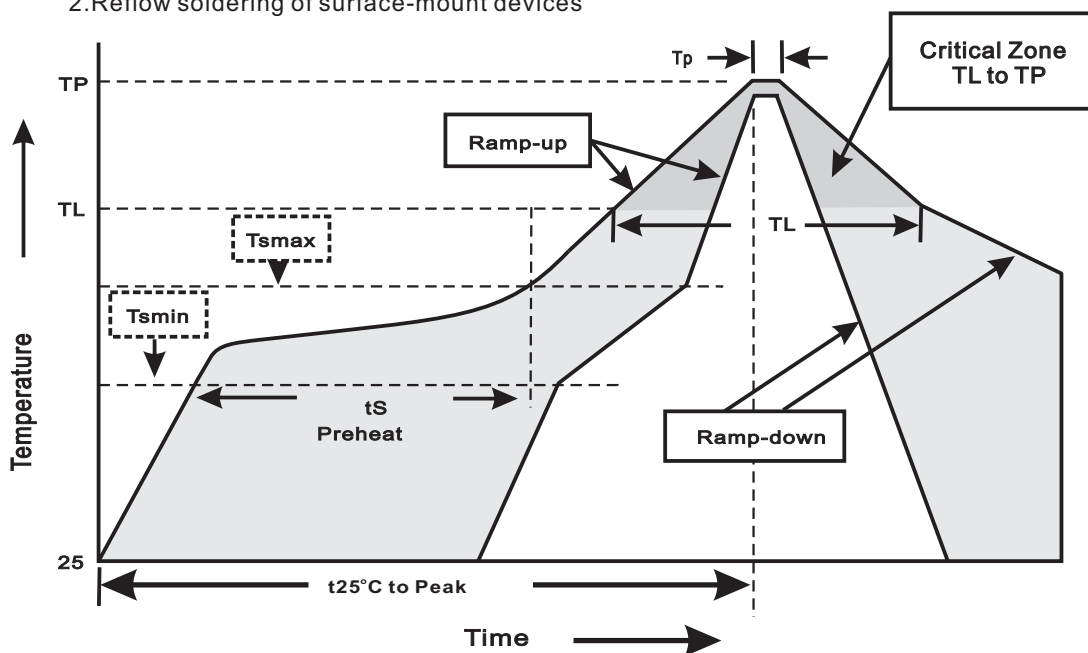
Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOD-523FL	7"	5,000	2.0	50,000	183*123*183	178	382*257*387	400,000	13.5

Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
2.Reflow soldering of surface-mount devices



3.Reflow soldering

Profile Feature	Soldering Condition
Average ramp-up rate(T_L to T_P)	$<3^{\circ}\text{C}/\text{sec}$
Preheat -Temperature Min(T_{min}) -Temperature Max(T_{max}) -Time(min to max)(t_s)	150°C 200°C $60\sim 120\text{sec}$
T_{max} to T_L -Ramp-upRate	$<3^{\circ}\text{C}/\text{sec}$
Time maintained above: -Temperature(T_L) -Time(t_L)	217°C $60\sim 260\text{sec}$
Peak Temperature(T_P)	$255^{\circ}\text{C}-0/+5^{\circ}\text{C}$
Time within 5°C of actual Peak Temperature(t_P)	$10\sim 30\text{sec}$
Ramp-down Rate	$<6^{\circ}\text{C}/\text{sec}$
Time 25°C to Peak Temperature	$<6\text{minutes}$

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High reliability test capabilities

Item Test	Conditions	Reference
1. Solder Resistance	at $260\pm 5^{\circ}\text{C}$ for $10\pm 2\text{sec.}$	MIL-STD-750D METHOD-2031
2. Solderability	at $245\pm 5^{\circ}\text{C}$ for 5 sec.	MIL-STD-202F METHOD-208
3. High Temperature Reverse Bias	$V_{\text{BR}}=V_{\text{BR MIN}}*80\%$ at $T_{\text{J}}=125^{\circ}\text{C}$ for 168 hrs.	MIL-STD-750D METHOD-1038
4. Pressure Cooker	$15P_{\text{SIG}}$ at $T_{\text{A}}=121^{\circ}\text{C}$ for 4 hrs.	JESD22-A102
5. Temperature Cycling	-55°C to $+125^{\circ}\text{C}$ dwelled for 30 min. and transferred for 5min. total 10 cycles.	MIL-STD-750D METHOD-1051
6. Humidity	at $T_{\text{A}}=85^{\circ}\text{C}$, RH=85% for 1000hrs.	MIL-STD-750D METHOD-1021
7. High Temperature Storage Life	at 175°C for 1000 hrs.	MIL-STD-750D METHOD-1031